



The design of an integrated XPS/Raman spectroscopy instrument for co-incident analysis

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XPS Surface Analysis

XPS

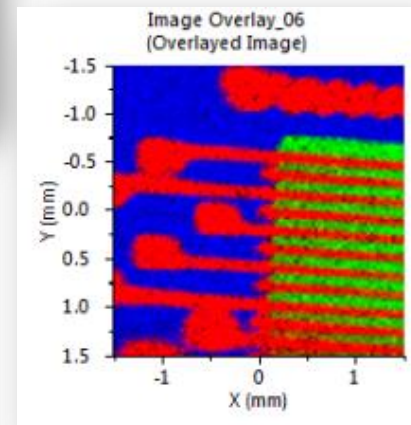
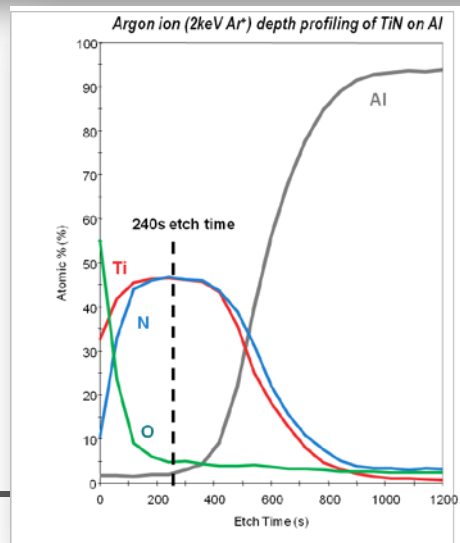
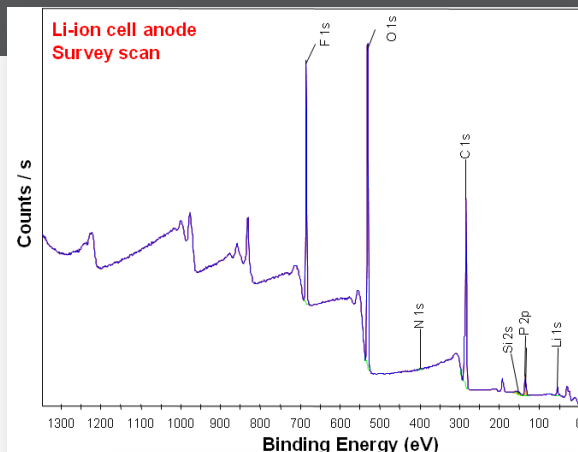
- Understand the surface chemistry

Imaging XPS

- Locate it on the surface

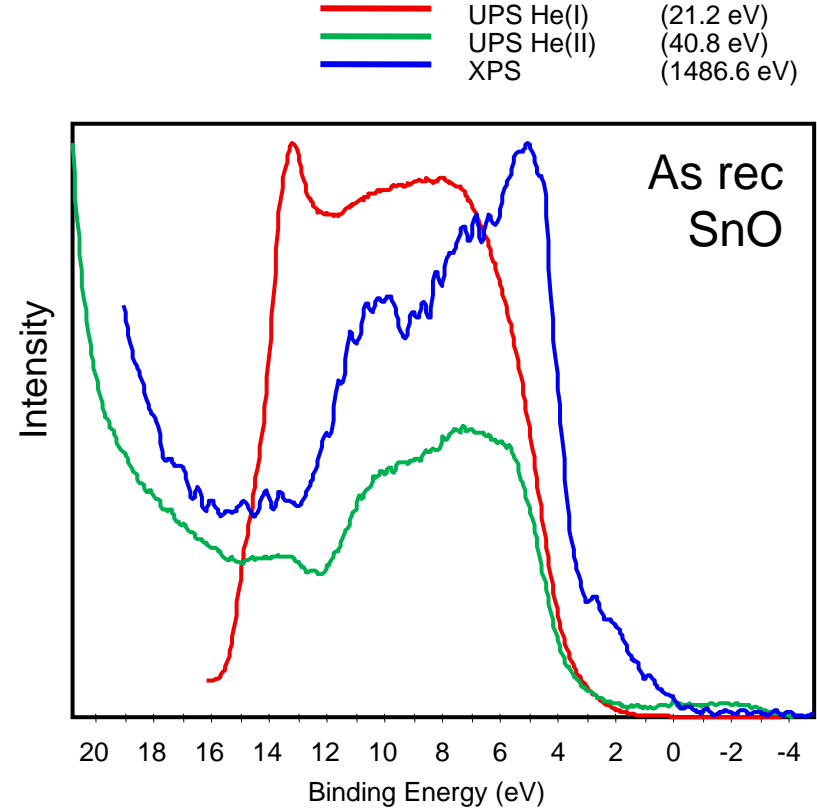
Depth Profiling

- Understand variation from surface to bulk



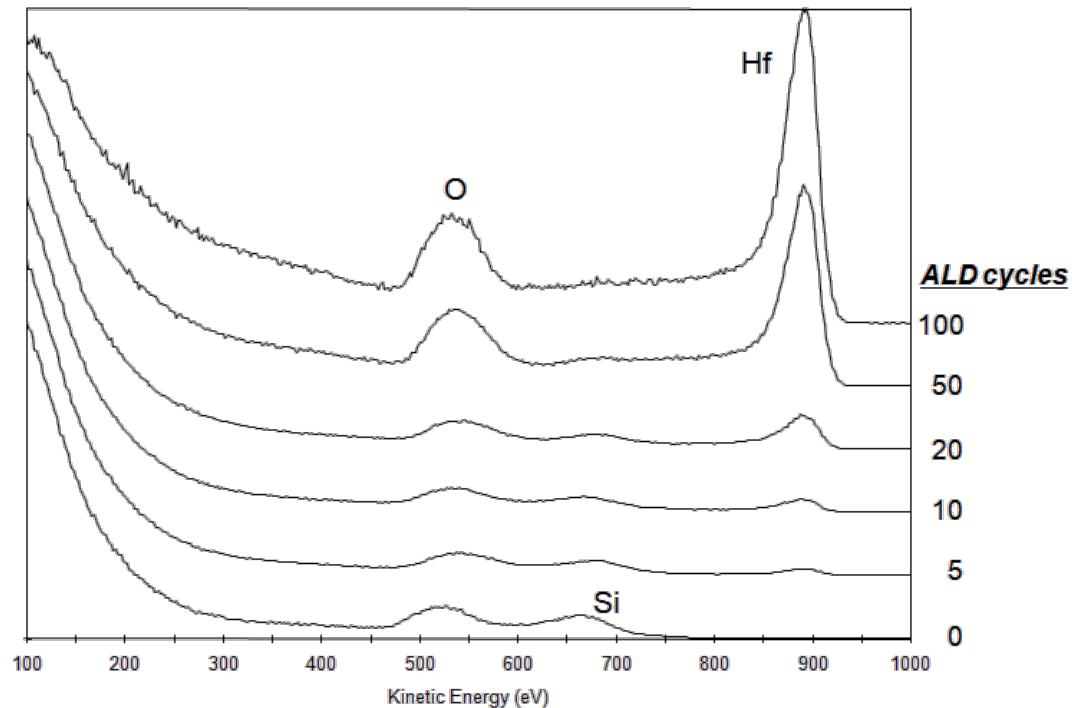
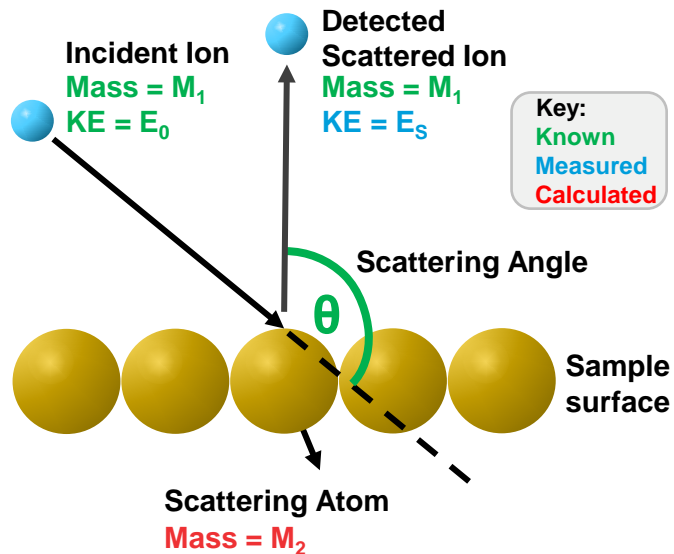
XPS + ...

- UV Photoelectron Spectroscopy



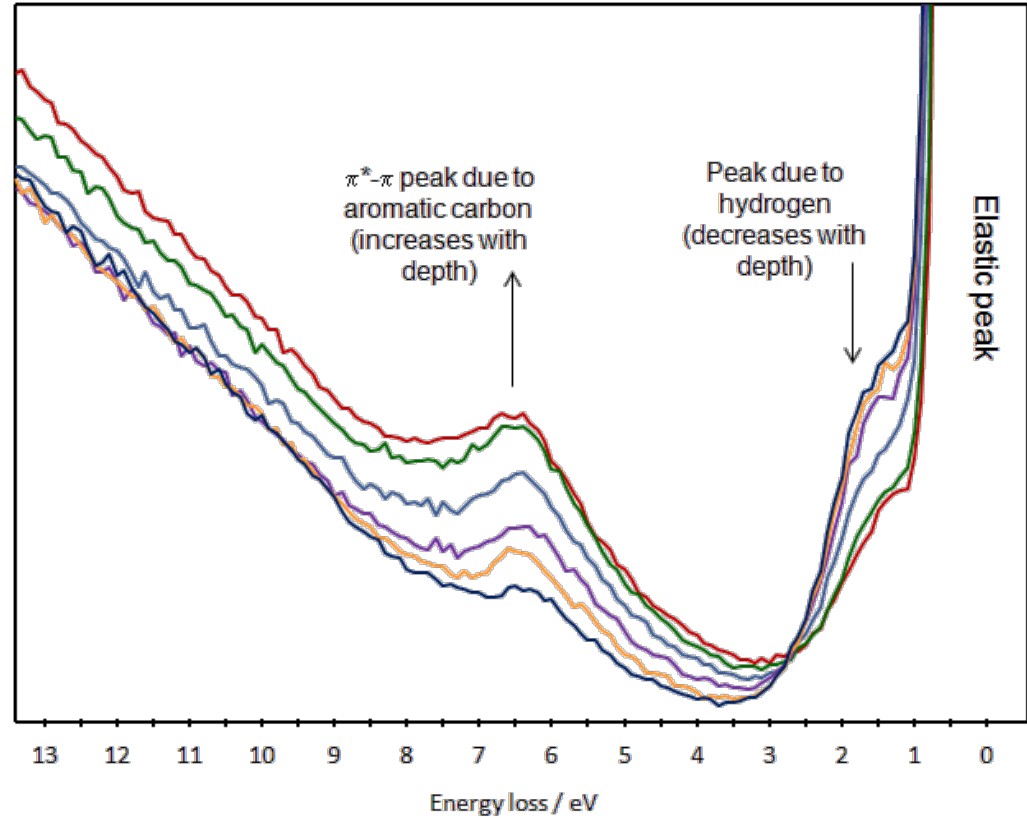
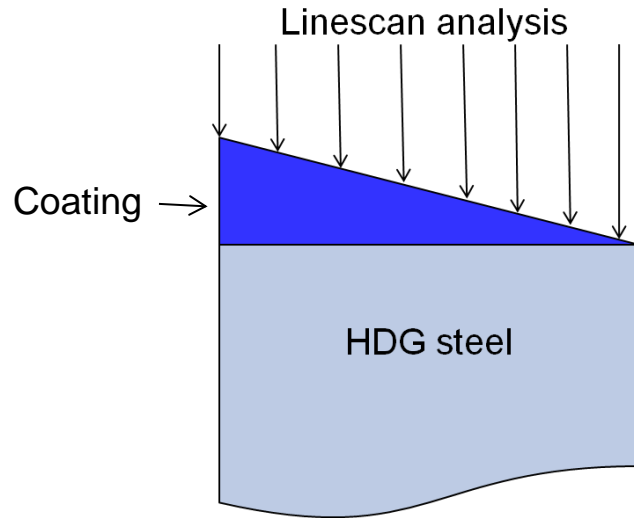
XPS + ...

- UV Photoelectron Spectroscopy
- Ion Scattering Spectroscopy



XPS + ...

- UV Photoelectron Spectroscopy
- Ion Scattering Spectroscopy
- **REELS**



(Some) other analysis techniques

XPS

Quantitative
chemical
state

Very
surface
sensitive



EDS

High spatial
resolution
imaging

Rapid
image
analysis



Raman

Chemical
bonding
information

Structural
information



FTIR

Chemical
bonding
information

Molecular
'fingerprint'



XRF

Elemental
composition

High
sensitivity



XRD

Structural
information

Crystallinity
and
composition



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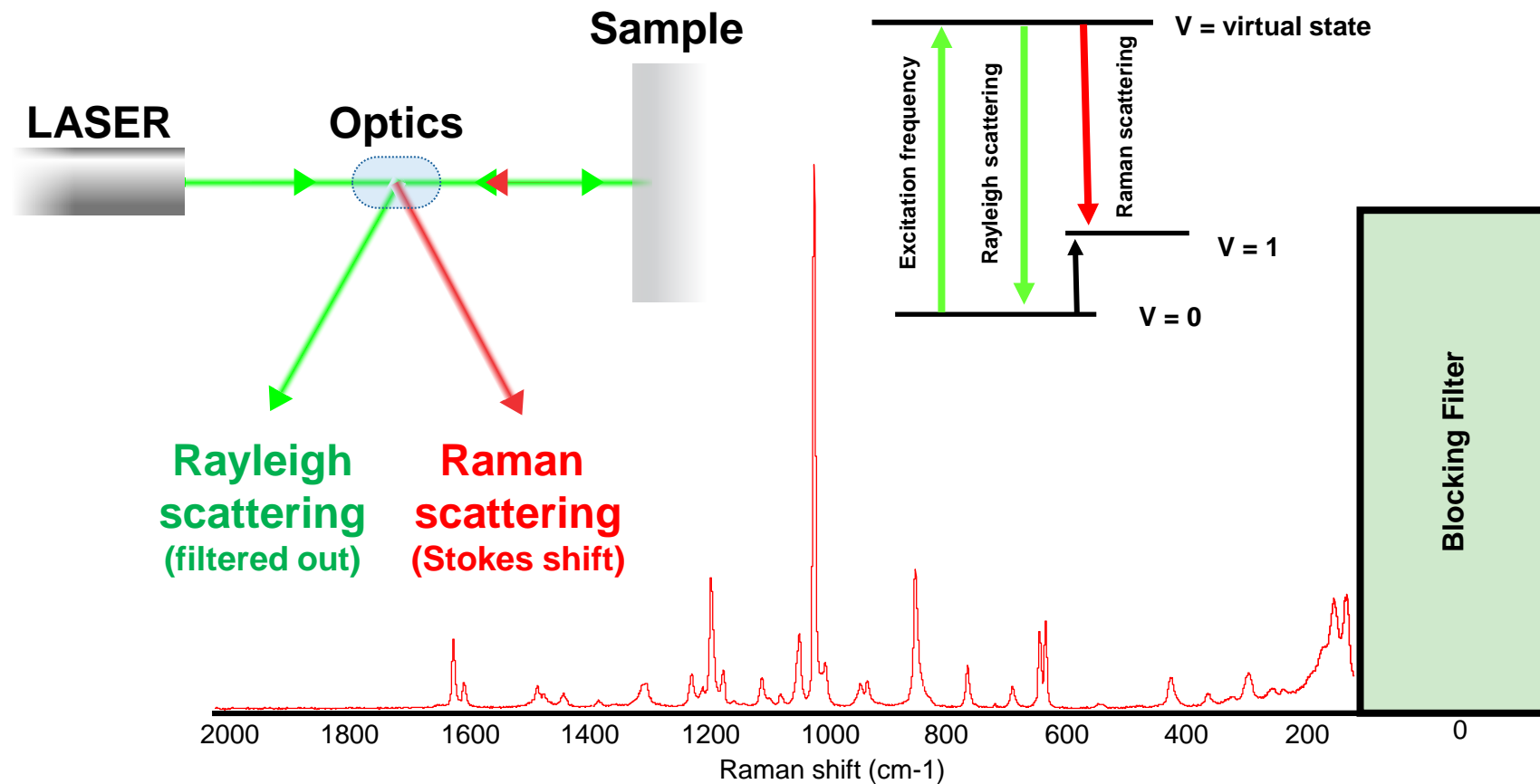
XRD

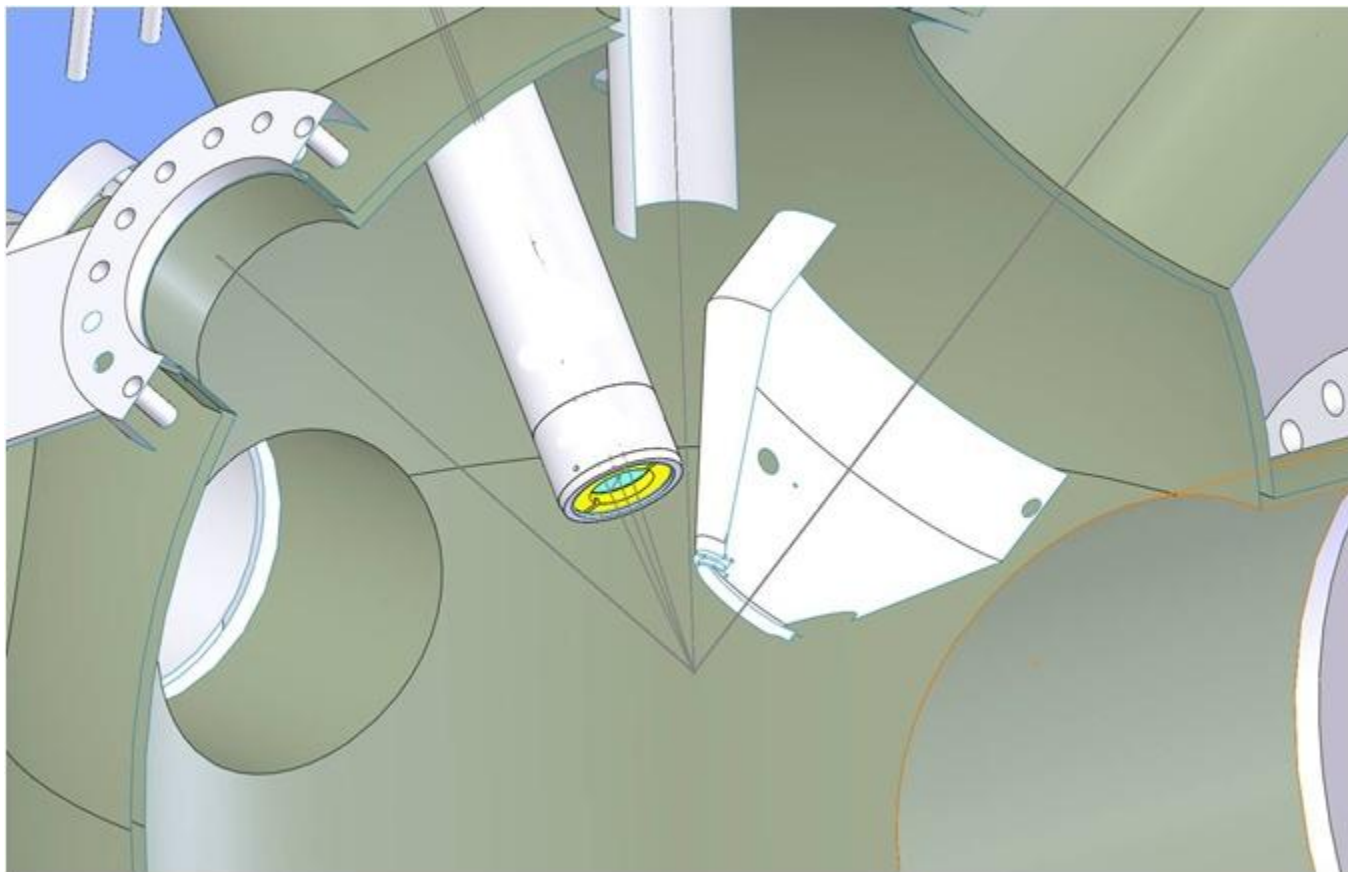
Structural
information

Crystallinity
and
composition

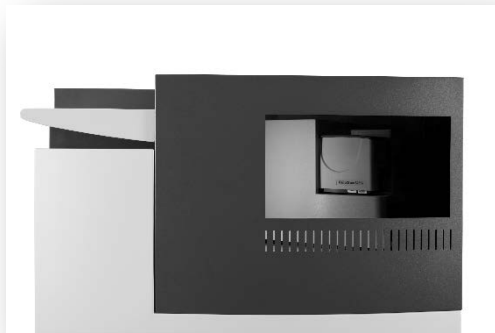


Raman Spectroscopy



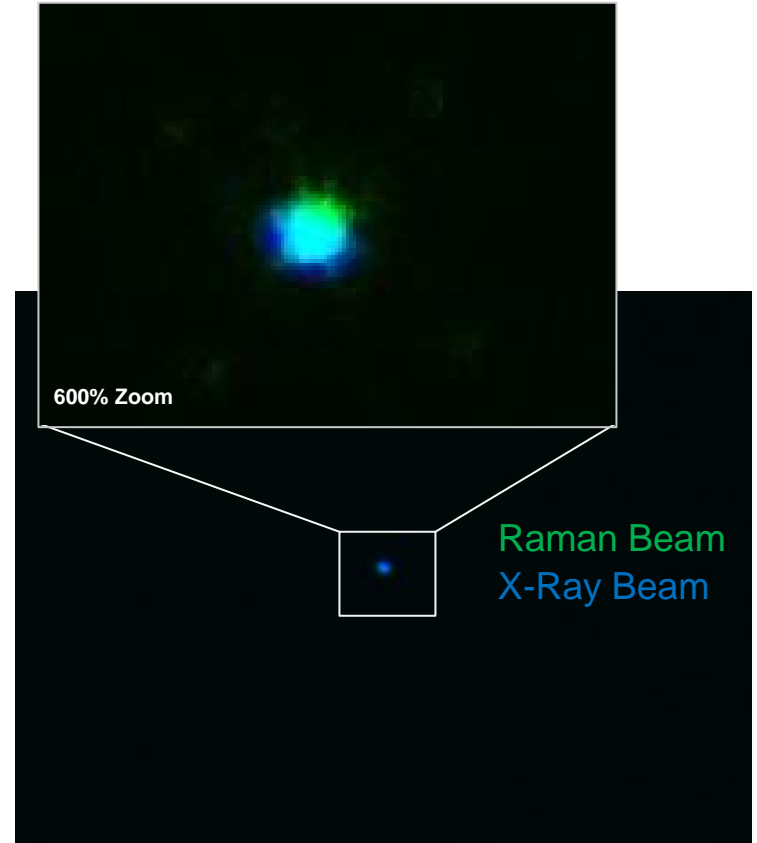


XPS with iXR Raman Spectrometer

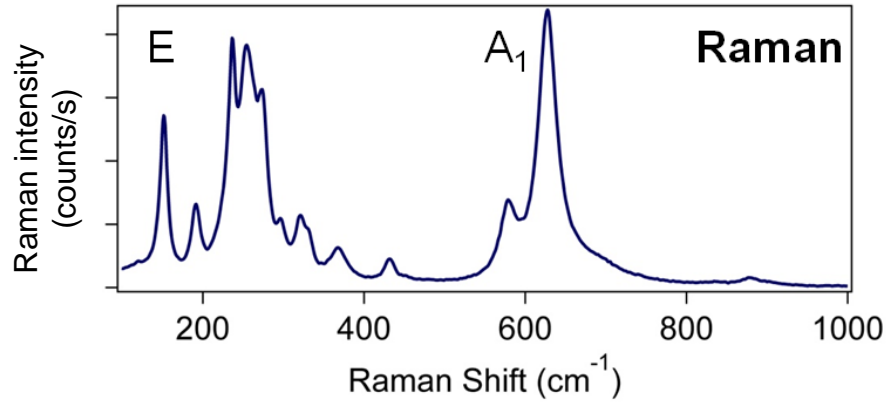
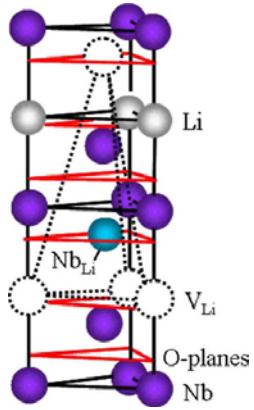


- Integration of small form factor Thermo Scientific™ iXR Raman spectrometer with
 - Thermo Scientific™ Theta Probe and
 - Thermo Scientific™ Nexsa XPS systems
- Allows simultaneous acquisition of Raman & XPS data
- Correlated analysis position
 - No need to move the sample to acquire data
 - Analysis area is matched
- Software control allows complex hybrid experiments

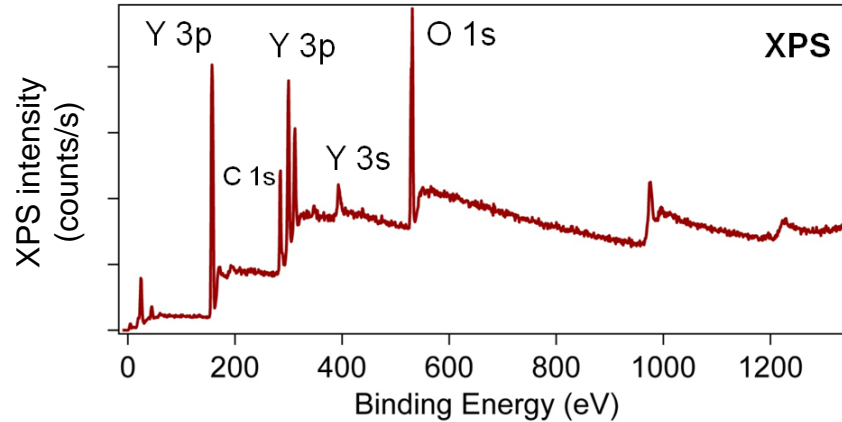
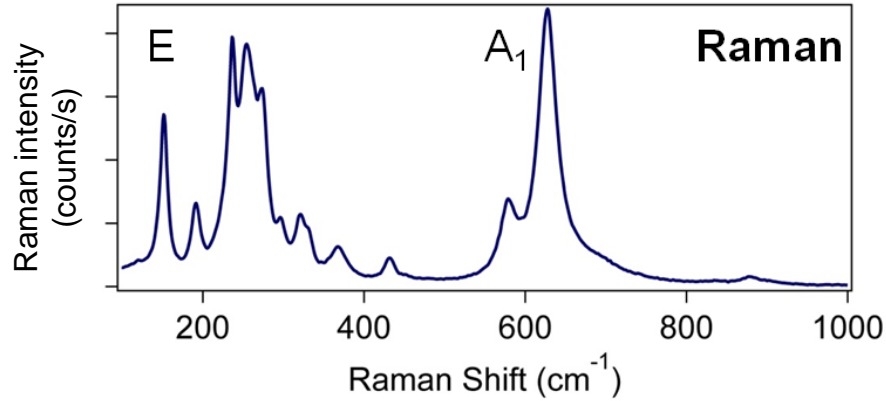
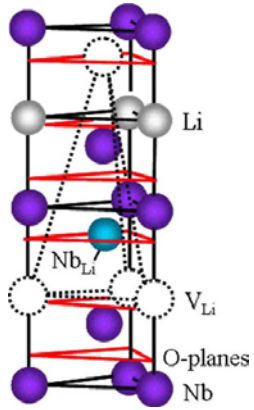
Co-alignment of analysis positions



Lithium niobate



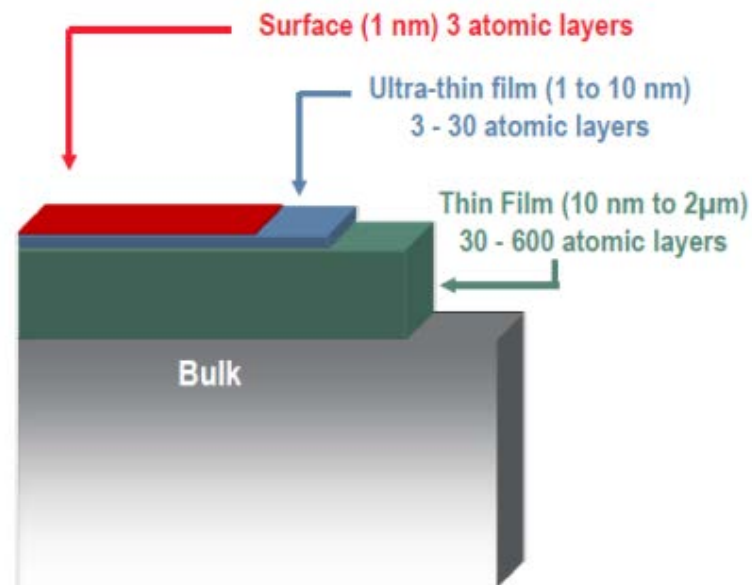
Lithium niobate...?



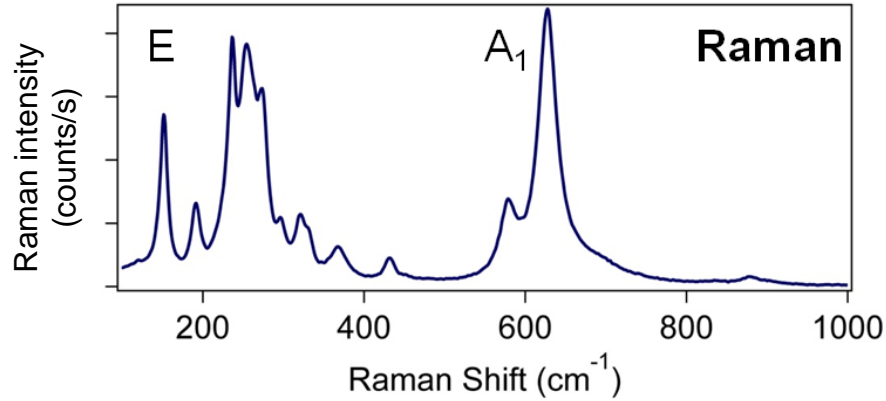
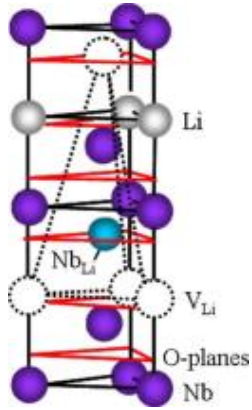
Bulk vs surface

- For strongly absorbing materials such as semiconductors, the Raman signal is acquired from a volume defined by the Raman penetration depth and the diameter of the laser beam
- A lower laser wavelength gives smaller penetration and provides chemical information closer to the samples surface
- Nominal XPS sampling depth is ≤ 10 nm

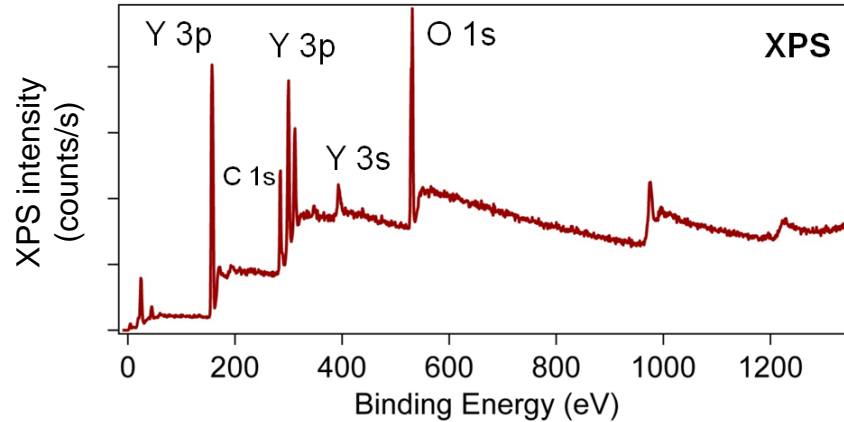
Laser Wavelength (nm)	Penetration Depth in Si (nm)	Penetration Depth in Ge (nm)	Penetration depth in a transparent Polymer Film (nm)
633	3000	30	>5000
514	760	19	>5000
488	570	18	>5000
457	310	18	>5000
325	10	9	>5000
244	6	7	>5000



Lithium niobate with yttrium oxide coating

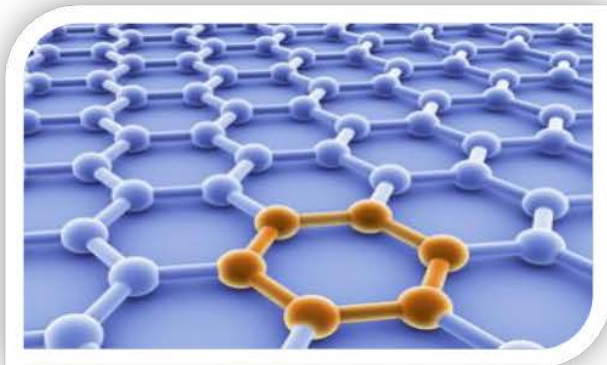


Bulk



Surface

Applications Area: Carbon



- Problems

- Graphene layers
- Catalyst contamination
- Chemical modification success
- QA/QC production

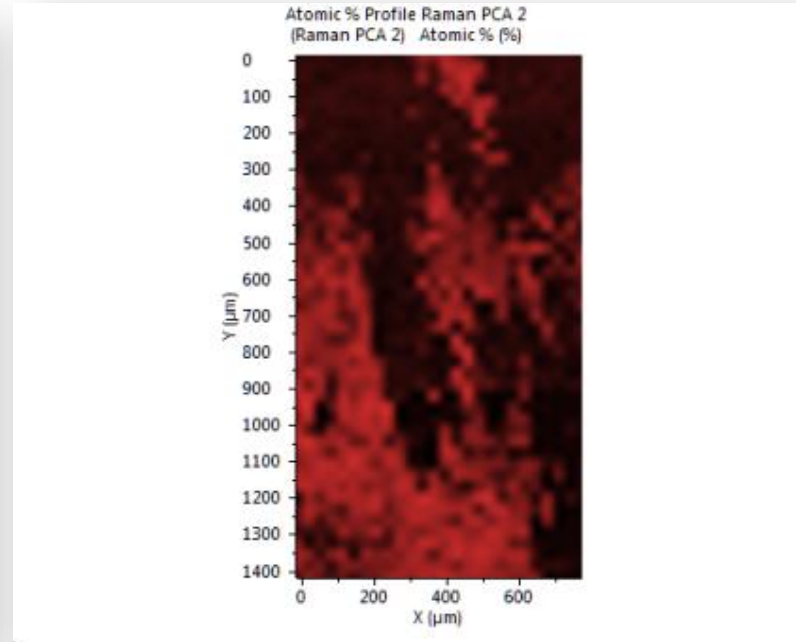
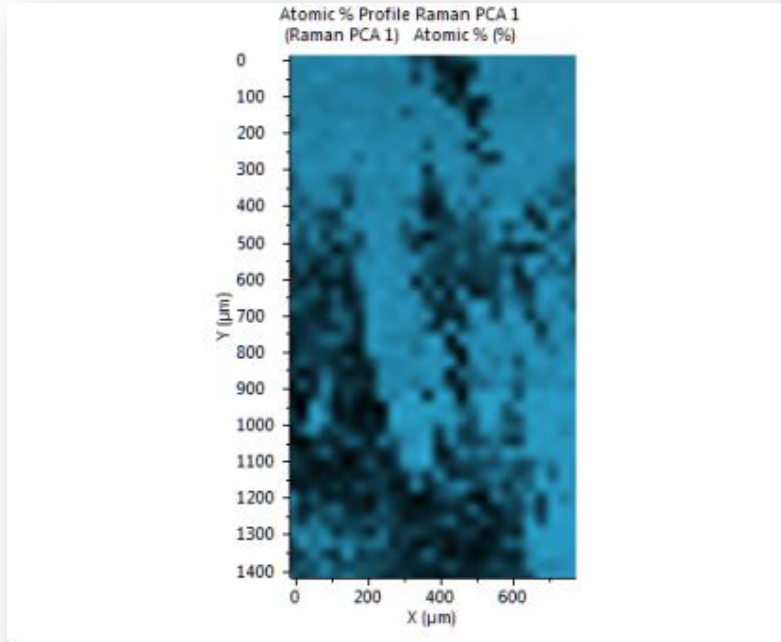
- Information from Raman / XPS / EDS

- Layer thickness
- CNT morphology
- Contaminant ID
- Chemical modification ID

- Example solutions

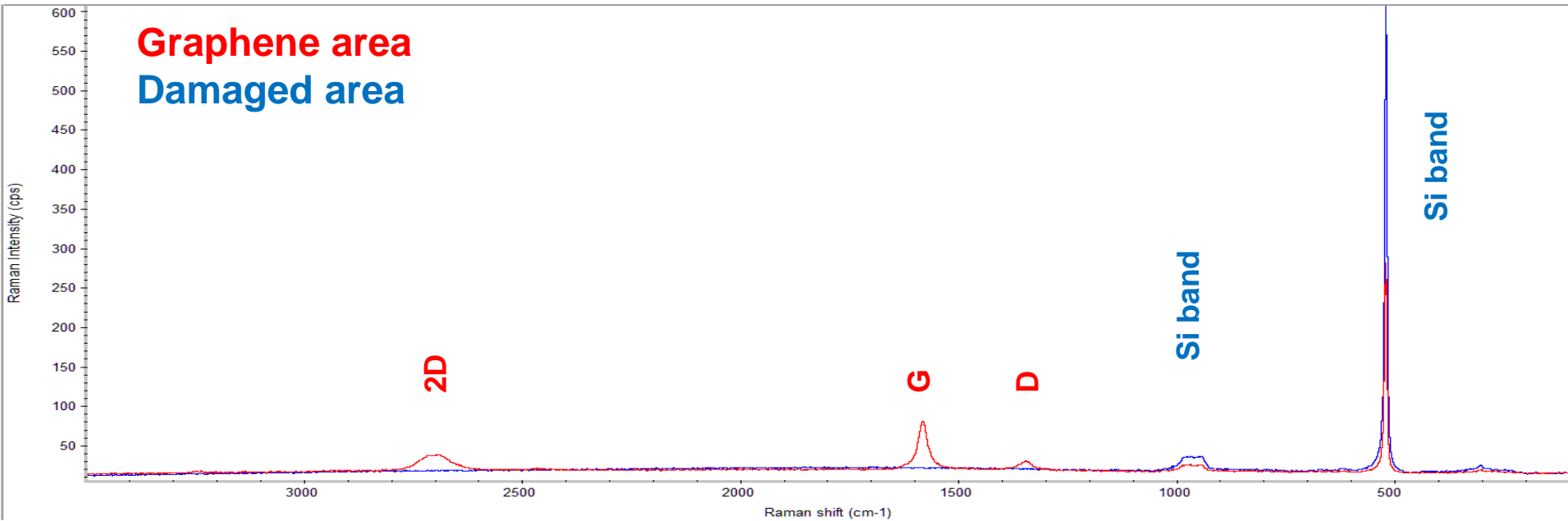
- Layer characterisation
- Modification quantification
- Nanotube characterisation
- Contaminant quantification

Graphene on SiO₂



Raman imaging of damaged graphene layer deposited on a silicon wafer
(Mapping controlled through Avantage software)

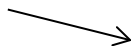
Graphene – PCA analysis of map



No graphene signal from damage zone

8 mW
50 μ m pinhole
15 x 10s acquisitions

Contamination



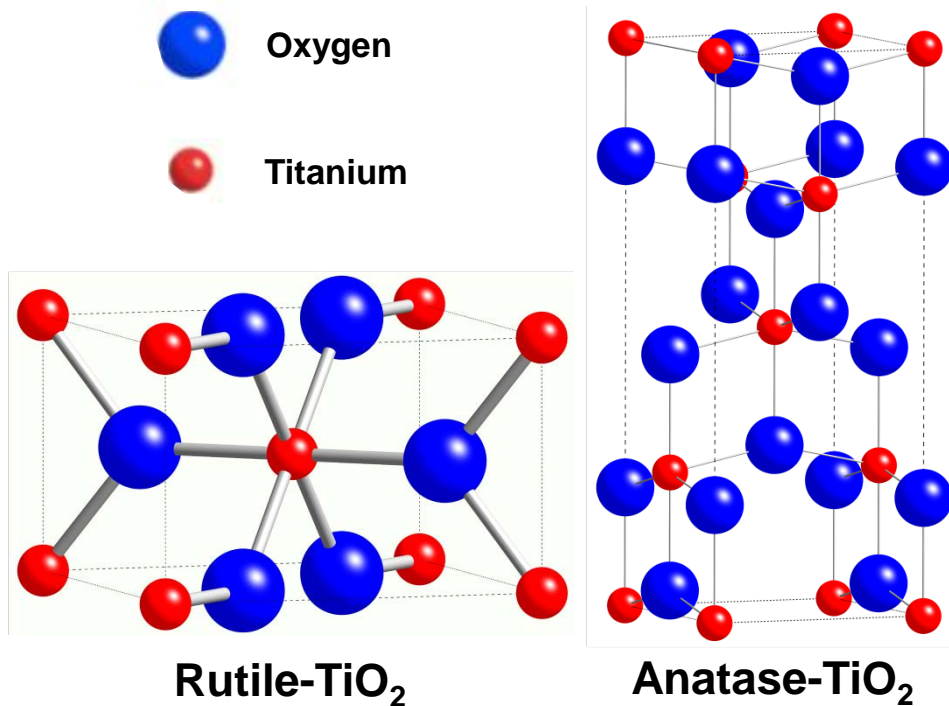
Contamination



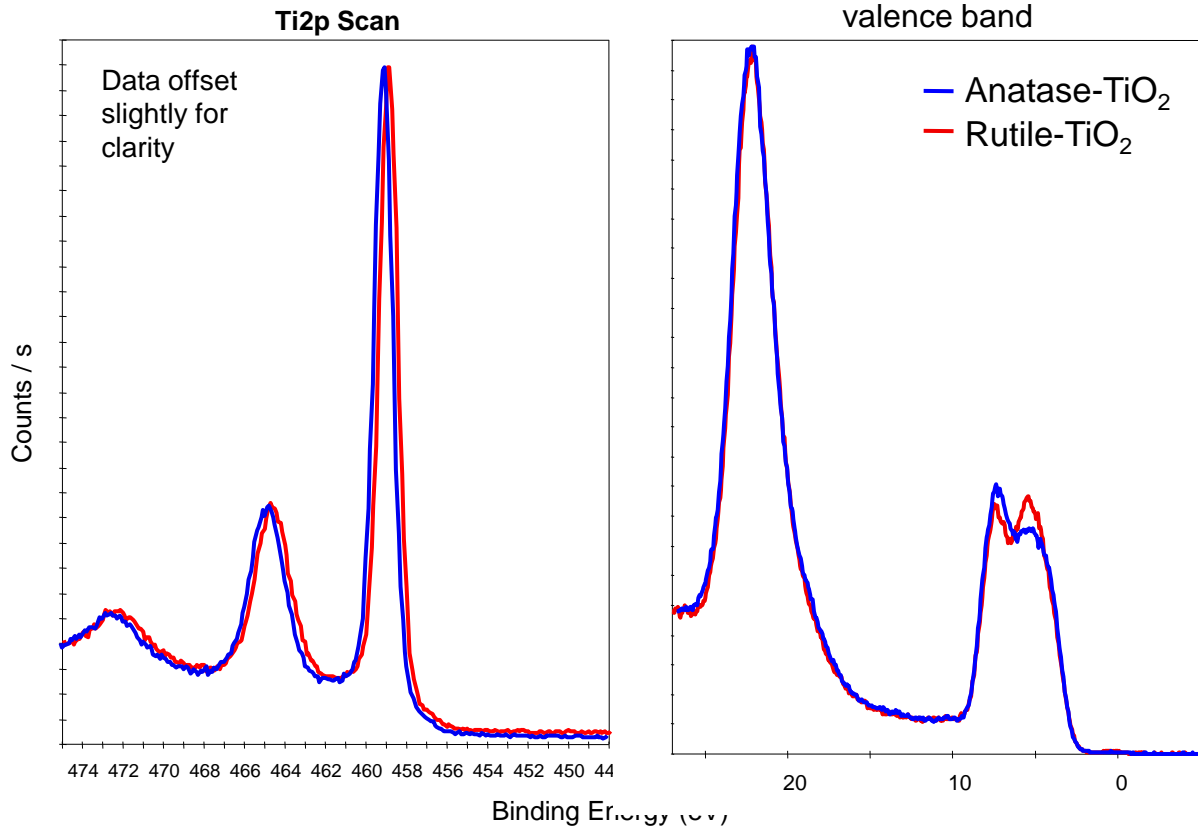
Both areas are contaminated by the adhesive material in the container that the sample was face down on.
Not visible in Raman, but easy to see in XPS.

- Titanium dioxide (TiO₂)

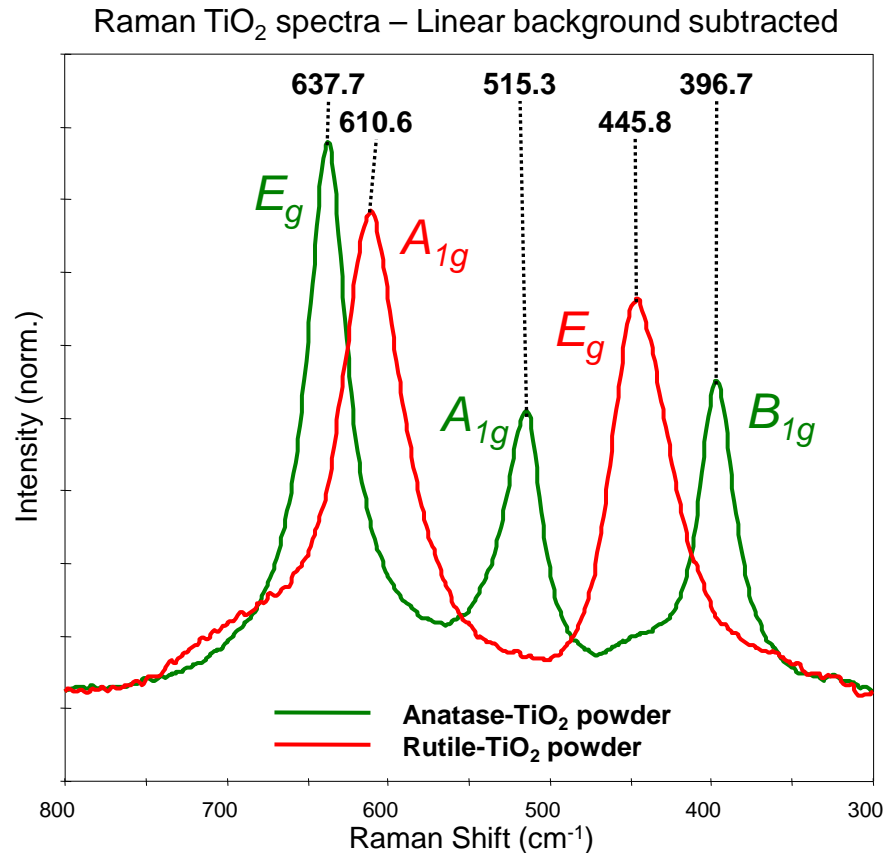
- Material of great interest due to its application in heterogeneous catalysis, dye-sensitised solar cells, bone implants and self-cleaning windows, amongst others
- Frontier material in the development of nanotechnology, nanoparticles, nanorods etc. fabricated to improve application properties
- Most abundant polymorphs are rutile and anatase
- Degree of mixing between two polymorphs influences material properties, such as catalytic activity

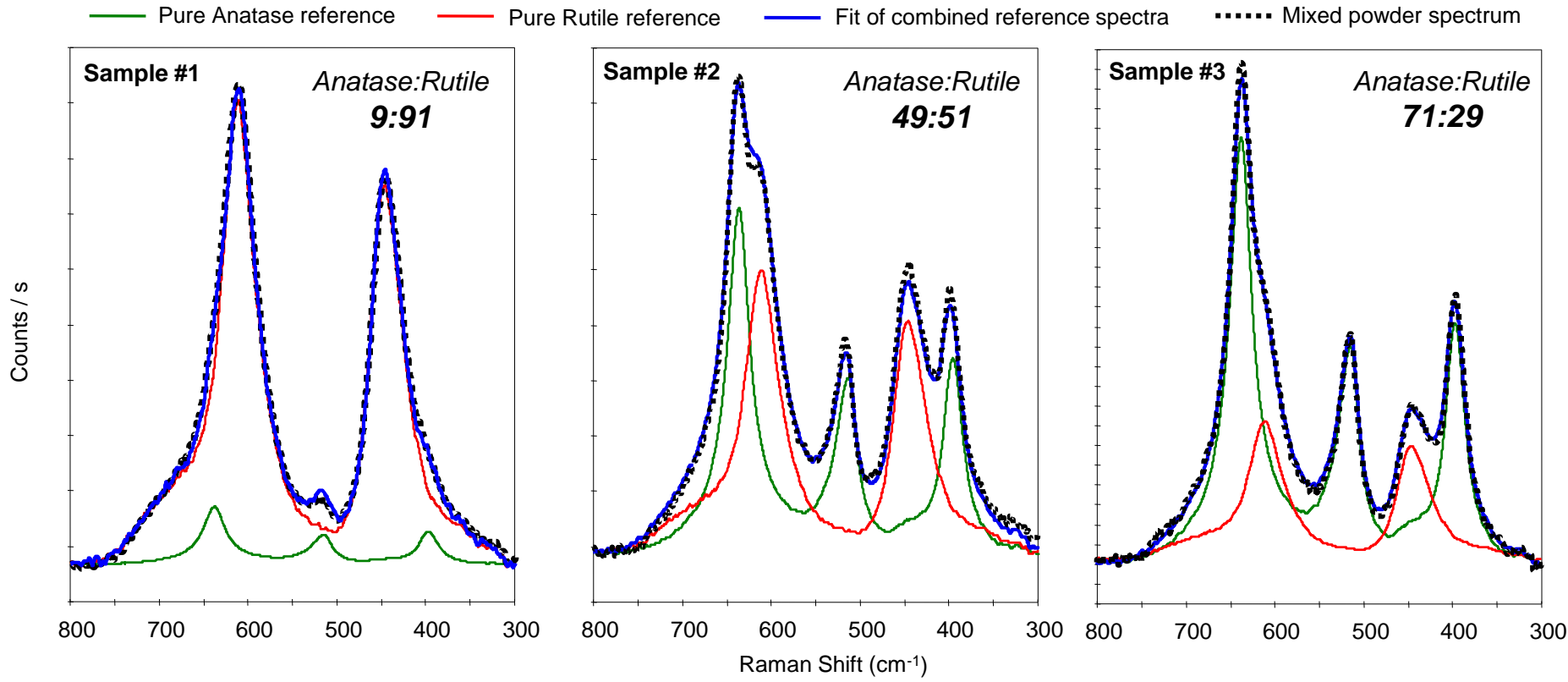


- Core level XPS spectra show identical elemental and chemical composition for pure anatase and pure rutile samples
- There is a slight variation in peak shape of valence band, however this is not conducive to easy quantification of the amount of polymorph.



- Raman spectra were acquired from pure anatase-TiO₂ and rutile-TiO₂ powders
- Pure spectra can be used as reference for determining the composition of powders with different proportions of anatase and rutile





Summary



- Adding extra analytical techniques increases the information that can be obtained.
- Matching the technique to the application is important
- Having co-incident analysis points ensures that the data is collected from the same point on the sample, but...
- ...consideration must be made of variations between analysis volumes.
- Offers opportunities for
 - Bulk – surface studies
 - Carbon nanomaterials
 - Coating analysis
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